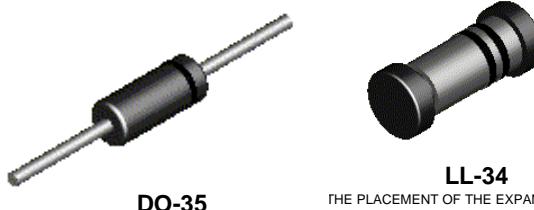




1N/FDLL 914/A/B / 916/A/B / 4148 / 4448



THE PLACEMENT OF THE EXPANSION GAP
HAS NO RELATIONSHIP TO THE LOCATION
OF THE CATHODE TERMINAL

COLOR BAND MARKING		
DEVICE	1ST BAND	2ND BAND
FDLL914	BLACK	BROWN
FDLL914A	BLACK	GRAY
FDLL914B	BROWN	BLACK
FDLL916	BLACK	RED
FDLL916A	BLACK	WHITE
FDLL916B	BROWN	BROWN
FDLL4148	BLACK	BROWN
FDLL4448	BROWN	BLACK

High Conductance Fast Diode

Sourced from Process D3.

Absolute Maximum Ratings*

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
W _{IV}	Working Inverse Voltage	75	V
I _o	Average Rectified Current	200	mA
I _F	DC Forward Current	300	mA
i _f	Recurrent Peak Forward Current	400	mA
i _{f(surge)}	Peak Forward Surge Current Pulse width = 1.0 second Pulse width = 1.0 microsecond	1.0 4.0	A A
T _{stg}	Storage Temperature Range	-65 to +200	°C
T _J	Operating Junction Temperature	175	°C

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

- 1) These ratings are based on a maximum junction temperature of 200 degrees C.
- 2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics

TA = 25°C unless otherwise noted

Symbol	Characteristic	Max		Units
		1N/FDLL 914/A/B / 4148 / 4448		
P _D	Total Device Dissipation Derate above 25°C	500 3.33	mW mW/°C	
R _{θJA}	Thermal Resistance, Junction to Ambient	300	°C/W	

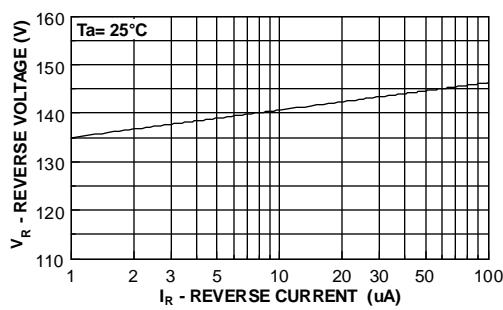
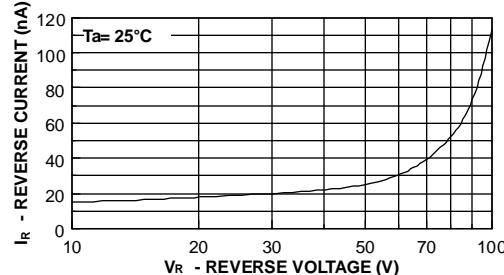
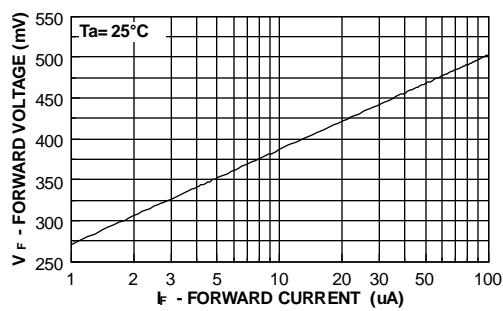
High Conductance Fast Diode

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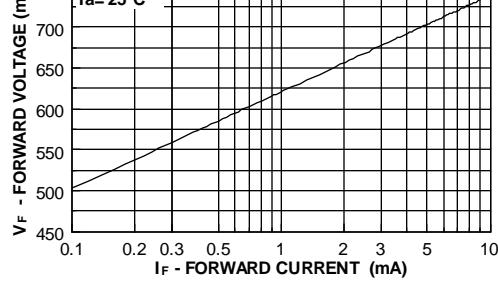
Electrical Characteristics

TA = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Max	Units
B _V	Breakdown Voltage	I _R = 100 µA I _R = 5.0 µA	100 75		V V
I _R	Reverse Current	V _R = 20 V V _R = 20 V, T _A = 150°C V _R = 75 V		25 50 5.0	nA µA µA
V _F	Forward Voltage 1N914B / 4448 1N916B 1N914 / 916 / 4148 1N914A / 916A 1N916B 1N914B / 4448	I _F = 5.0 mA I _F = 5.0 mA I _F = 10 mA I _F = 20 mA I _F = 30 mA I _F = 100 mA	620 630	720 730 1.0 1.0 1.0 1.0	mV mV V V V V
C _O	Diode Capacitance 1N916/A/B / 4448 1N914/A/B / 4148	V _R = 0, f = 1.0 MHz V _R = 0, f = 1.0 MHz		2.0 4.0	pF pF
T _{RR}	Reverse Recovery Time	I _F = 10 mA, V _R = 6.0 V (60 mA), I _{rr} = 1.0 mA, R _L = 100 Ω		4.0	nS

Typical Characteristics**REVERSE VOLTAGE vs REVERSE CURRENT**
BV - 1.0 to 100 µA**REVERSE CURRENT vs REVERSE VOLTAGE**
IR - 10 to 100 V**FORWARD VOLTAGE vs FORWARD CURRENT**
VF - 1 to 100 µA**FORWARD VOLTAGE vs FORWARD CURRENT**

VF - 0.1 to 100 mA

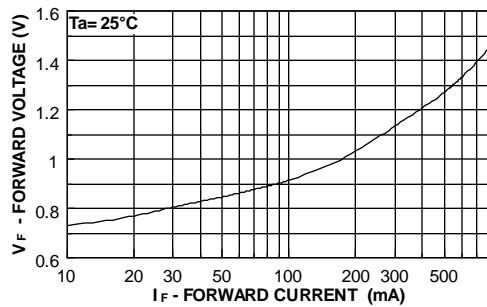


High Conductance Fast Diode

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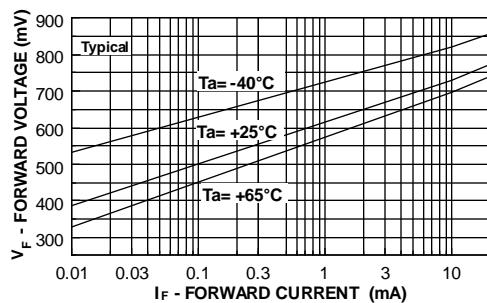
Typical Characteristics (continued)

FORWARD VOLTAGE vs FORWARD CURRENT
VF - 10 to 800 mA

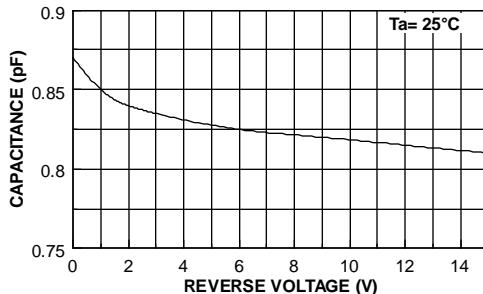


VF - 0.01 - 20 mA (-40 to +65 Deg C)

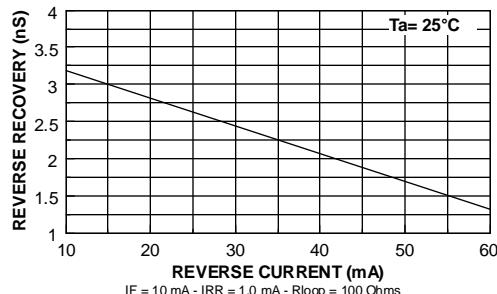
FORWARD VOLTAGE vs AMBIENT TEMPERATURE



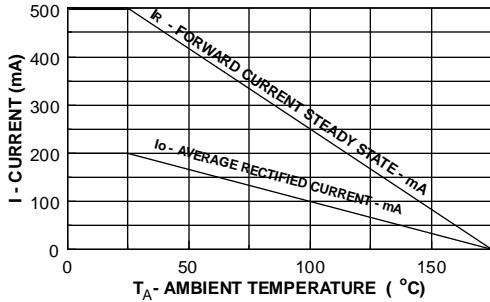
CAPACITANCE vs REVERSE VOLTAGE
VR = 0.0 to 15 V



REVERSE RECOVERY TIME vs REVERSE CURRENT



Average Rectified Current (I_o) & Forward Current (I_F) versus Ambient Temperature (T_A)



POWER DERATING CURVE

